Form PTO 1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO.	SERIAL NO. NEW APPLICATION				
(Modified)				220137US0					
				APPLICANT					
LIST OF REFERENCES CITED BY APPLICANT				Katsuhisa INOUE, et al.					
				FILING DATE		GROUP			
				HEREWITH					
				U.S. PATENT DOCUMENTS					
EXAMINER INITIAL	·	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE		
m	AA	4,639,468	01/27/87	Romeo RONCUCCI, et al.					
	AB								
	AC						To		
	AD						2,00		
	ΑE						0.8 0.8		
	AF						200		
	AG						3		
	AH						7		
ź,	AI								
	AJ								
	AK								
	AL								
	AM								
	AN								
			FO	REIGN PATENT DOCUMENTS					
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO			
	AO	5-271035 •	10/19/93	JAPAN (English Abstract Only)					
	AP	5-271036 ₺	10/19/93	JAPAN (English Abstract Only)					
	AQ	2000-501430 •	02/08/02	JAPAN (with English Abstract, Corresp WO 98/40046)	onds to		x		
	AR	WO98/40046	09/17/98	WIPO					
	AS	55-143944	11/10/80	JAPAN (with English Abstract, Corresp US 4,639,468)	onds to		Х		
	AT	WO98/03472	01/29/98	WIPO	····				
	AU	9-118606	05/06/97	JAPAN (English Abstract Only)					
	AV	2000-302651	2651 10/31/00 JAPAN (with English Abstract)				X		
		OTHER RE	FERENCES (Including Author, Title, Date, Pertinen	t Pages, e	tc.)			
	AW								
	AX								
	AY								
	AZ				Addi	tional Refe	rences sheet(s) attached		
Examiner		OXX.	MI		Date Cor	Date Considered U/26/07			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered, include copy of this form with next communication to applicant.									

(B		2 2002				SHE	ЕТ 🧲	
Form PTO 1449 (Modified) PATENT AND TRADEMARK OFFICE				ATTY DOCKET NO. 220137US0	SERAL NO. CA. (1) (2) (2) (1) (2) (1) (2) (1) (2) (1) (2) (1) (2) (2) (2) (2) (2) (2) (2) (2) (2) (2			
LIST OF	REFEF	RENCES CITED BY API	PLICANT	APPLICANT Kats	uhisa INOUE	et al.	NER	1600
				FILING DATE March 4, 2002	1619			
				U.S. PATENT DOCUMENTS				
EXAMINER INITIAL		DOCUMENT NUMBER			SUB CLASS	SUB FILING DATE CLASS IF APPROPRIATE		
	AA	4,639,668	01/27/87	P. PETIT, et al.				
	AB							-
	AC							
÷	AD							
···	AE							
	AF							
·	AG							
	AH							
	Al							
	AJ							
	AK							
	AL							
	AM							
	AN							
_			FO	REIGN PATENT DOCUMENTS				
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLA YES		ATION NO
	AO	1 165 038	03/12/64	GERMANY				X
	AP	WO 98/40046	09/17/98	WIPO				
	AQ							
	AR		<u> </u>					
	AS							
	AT							
-	AU							
	AV						_	
	•	OTHER RE	FERENCES	(Including Author, Title, Date, Per	tinent Pages, e	etc.)		
	AW							
	AX							
	AY							
	Δ7					itional Poto	rances s	sheet(s) attached

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Examiner

Date Considered

ATTY DOCKET NO. SERIAL NO. U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE Form PTO 1449 (Modified) 220137US0 10/086,873 **APPLICANT** LIST OF REFERENCES CITED BY APPLICANT Katsuhisa INOUE, et al. GROUP FILING DATE 1619 March 4, 2002 **U.S. PATENT DOCUMENTS EXAMINER** DOCUMENT SUB **FILING DATE** CLASS DATE NAME **CLASS** IF APPROPRIATE NUMBER INITIAL AA AB AC AD ΑE ΑF AG AH ΑI AJ ΑK ΑL ΑМ AN **FOREIGN PATENT DOCUMENTS** TRANSLATION DOCUMENT DATE COUNTRY NUMBER YES NO GERMANY (corr. US 4,639,468 was filed on 217 513 01/16/85 Х ΑO March 4, 2002) AP AQ AR AS AT ΑU ΑV OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.) AW AY ΑZ Additional References sheet(s) attached **Date Considered** Examiner *Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.